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## AMENDMENT TO THE CLAIMS:

The following list of claims will replace all prior versions of claims in the application:

- 1. (currently amended) A wafer planarization system comprising:
- an electrical source having a first electrode and a second electrode;
- a polishing pad carrier connected to said first electrode;
- a workpiece carrier connected to said second electrode;
- a conditioning tool comprising an abrasive surface adapted to condition said polishing pad; and

an electrical insulator configured to isolate said abrasive surface from at least one of said first electrode and said second electrode;

wherein said conditioning tool comprises said electrical insulator; wherein said conditioning tool further comprises an electrically insulated conditioning disk comprising said abrasive surface and a substrate proximate said abrasive surface; and wherein said conditioning disk further comprises a carrier affixed to said substrate.

## 2-5. (canceled)

- 6. (currently amended) The system of claim [[5]] 1 wherein said carrier is an electrical insulator.
- 7. (original) The system of claim 6 wherein said carrier is formed from polycarbonate.
- 8. (currently amended) The system of claim [[4]] 1 wherein said substrate is conductive.
  - 9. (original) The system of claim 8 wherein said substrate comprises nickel.

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- 10. (original) The system of claim 9 wherein said abrasive surface comprises a plurality of abrasive particles affixed to said substrate with a metal matrix.
- (original) The system of claim 10 wherein said abrasive particles comprise diamonds.
  - 12. (original) The system of claim 10 wherein said metal matrix comprises nickel.
- 13. (currently amended) A method of conditioning an electrochemical-mechanical polishing pad comprising:

electrically insulating an abrasive surface of a conditioning tool; wherein said conditioning tool comprises an electrically insulated conditioning disk comprising a substrate proximate said abrasive surface and a carrier affixed to said substrate;

contacting said abrasive surface with said polishing pad; and moving said abrasive surface relative to said polishing pad.

- 14. (canceled)
- 15. (original) The method of claim [[14]] 13 wherein said carrier is an electrical insulator.
- 16. (original) The method of claim 15 wherein said carrier is formed from polycarbonate.

17-20. (canceled)